Burn-in & Test Socket Workshop

March 7 - 10, 2004 Hilton Phoenix East / Mesa Hotel Mesa, Arizona

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Technical Program

Session 2 Monday 3/08/04 10:30AM THERMAL ANALYSIS

"FEA Analysis Of A Burn-in Socket Contact - Beware The Use Of Simple Models"

Dr. James A. Forster – Texas Instruments Prasanth Ambady – Texas Instruments Ray Mandeville – Texas Instruments

"Chips On Fire, New Approach To Thermal Management"

Kevin Moody – Kulicke & Soffa

"Heat Sink Modeling And Design For Dissipating High Heat"

S. Kumaran – Trio-Tech International

FEA Analysis of a Burn-in Socket Contact - Beware the use of Simple Models.

Prasanth Ambady, Ray Mandeville and James Forster

> **Texas Instruments,** Sensors & Controls, Attleboro, MA

2004 Burn-in Test Socket Workshop - March 7-10, 2004 Hilton Phoenix East/Mesa Hotel Mesa, Arizona





Outline

- Introduction
- Brief introduction to the history and process of design
- What is FEA
- Examples of the analysis of some contacts
- Concluding remarks

Introduction/Objective

- A personal perspective of how we got here the design process
- Share some information about the use of FEA in the analysis of contacts
- Not a detailed introduction to FEA
- Educate/inform
- This is not a recommendation of any specific software package
- BUT MOST OF ALL
 - my objective is to be interesting and to stimulate you to think about the design process, and to have some fun

BiTS and FEA

- A review of the BiTS archives shows only one paper on FEA - from 2001 titled:.
 "A Finite Element Analysis of Solder Balls on BGA Package in Sockets During Burn-in" by Al Sugarman and Ariane Loranger
- The presentation examined the complex interactions between contacts and solder balls at burn-in temperatures.

BiTS and FEA

Result from Sugarman and Loranger



Two arm tweezers design. Total Strain after 42 days (1/2 Model)



Two arm tweezers design. Model used for FEA of double tweezers design



Schematic of two arm tweezers style contact.



Figure 7. Two arm tweezers design (1/2 Model). Equivalent Stress Static Load at 0 hours and 125°C.

Slide 12

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But First Let's take a Few Steps Back

- What is Design and how do we "Do it"?
- Man has always strived to leave his impact on the "landscape".

"Man is a singular creature... he is not a figure in the landscape - he is a shaper of the landscape. In body and mind his is the explorer of nature, the ubiquitous animal who did not find but has made his home in every continent." - Jacob Bronowski

Lets examine a few examples

Early Attempts

 Man's earliest designs focused on monuments, housing and weapons – This was survival





 The beginnings of science and understanding Da Vinci (1452), Galileo (1564)















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An Understanding of Materials





1676 - Robert Hooke
 The birth of "elasticity" and the
 understanding of material properties.

 Proposes the relationship between
 force and extension of a spring.

e = **f.(F)**

1804 - Thomas Young Extended Hooke's law into the universal realtionship between stress and strain



The Development Process - Correlating Experiments and Theory • 1896 to 1903 The Wright brothers



Developed a formal approach to understanding the relationship between science and engineering. Perhaps the first "Research and Development program" Built 3 gliders to understand

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"flight".



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The Impact of Education

- Post World War era.
- Formal education of many people in sciences and math enabled the creation of the "Design Engineer"



The Impact of Analysis on Design

Kelly Johnson and the Lockheed Skunk Works



Intuitive but the broad understanding of design and strength of materials led to "analysis" of designs before parts were made. The engineers tools were still simple

The Design Engineer

- The 1950's
- Rooms of design engineers –
- Tools slide rules and log tables laborious hand calculations of stress and strain





The Design Engineer's Tool



Pacing the Great New Age of Engineering

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The Impact of Computers

- Development of powerful mainframe computers allowed thousands of "calculations".
- Some design engineers used this new tool to analyze complex problems.
- The Finite Element Method is developed
- But computers are expensive and difficult to use





The Analyst is Born

The analyst

- Often a math or engineering graduate
- Capable of integrating the complex interface between problem definition, the mathematics of a classical solution and the computer language
- Punched cards for input
- A stack of pages and pages of "green bifold" – The output with rows and columns of numbers.

The Personal Computer

- Put massive computing power and analytical capability on every desktop.
- Development of GUI (Graphical User Interfaces

 Windows) and analytical software removed the last barriers between complex mathematics and easy to use software and graphical representations of the solution.
- 3D Design software and FEA programs enable users to perform complex calculations without a detailed understanding of the "code" behind the user interface.

The cost of FEA in the 1970's

 "In inflation adjusted dollars, a PC capable of FEA can be purchased for the commercial price of ONE run of an FEA analysis on a scientific mainframe in the late 1970's.

That doesn't even begin to discuss the difficulty of the output of results. You almost needed a hard hat to wear around the stacks of printout that could accumulate" - Peter Budgell – FEA Consultant

The cost of FEA in the 1970's

- In 1968 a typical UNIVAC 1108 a 1.3 MHz CPU with half a megabyte of RAM and 100 megabyte hard drive cost \$1.6 million.
- Oh, and you want a printer too...?
- Shipments of the IBM's new 3031 processors begin in the first quarter of 1978.

 The new 3031 processor complex with two million characters of main memory, can be leased for \$25,000 monthly.

Purchase prices are \$1,000,000, to \$1,345,000

What is FEA? – (Conceptually)

- FEA is a numerical analysis technique used to solve engineering problems for structural and field applications.
- The objective of FEA is to break a complicated structure into small, easy to analyze segments, called finite elements.
- Each element is formulated to obey the governing physics using numerical computational techniques.
- The elements are assembled into a matrix of algebraic equations. This matrix is solved computationally.

What is FEA? – (Practically)

Typically - FEA software consists of three steps:
▶ Pre Processing,

- ≻Analysis,
- Post Processing.

What is FEA? – Pre Processing

Pre Processing includes

- Geometric modeling, mesh generation –
- > Application of the boundary conditions and the load
- > Assigning material and geometric properties.



Material BeCu C17200HT		
Yield strength	1200 Mpa	174 ksi
Tensile strength	1300 Mpa	200 ksi
Modulus of Elasticity	130 GPA	17 msi

Pre Processing – Assigning Material Properties Image of screen as designer performs analysis.



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What is FEA? – (Analysis)

- <u>Analysis</u> portion of the FEA process is the most complex with applications such as:
 - Structural
 - Thermal
 - Electrical
 - Magnetics
 - Fluids

What is FEA? – (Post Processing)



 Post Processing Displays the results in graphical form such as -contour plots, -animated "movies", -XY - data plots, etc.. This improves communication of the results with customers, suppliers, other engineers and management

The Language of FEA

 Those "experienced" in FEA understand the meaning and significance of

plane strain total lagrangian stress strain elastic modulus symmetry cyclic symmetry plane stress tangent modulus tetrahedral vs hexahedral element and

lagrangian criteria yield criterion **Plasticity** von mises convergence eigenvalue damping linear vs non-linear **Eigenvector** element axisymmetric structural lagrangian updated

What Do I Need to Know to do FEA?

- Do I know my product what it's designed to do, and the environment in which it performs?
- Do I know what tools are applicable to simulate my product and its environment?
- Do I know the extent to which the tools I've chosen can simulate the "real world"? (Linear, nonlinear, coupled physics ??)
- Have I correlated the computer simulation with testing to validate my tools and modeling procedures? (Are the results any good??)

Why FEA? Product Development – Prototyping

- What you see is what you get.
- Easy to move from prototype to production.
- Time consuming.
- Expensive.
- Difficult to optimize a design or manufacturing process.
- Usually the outcome is a "pass" or "fail".
- Not much insight in the "reasons" that lead to failure.

Why FEA? Product Development – FEA Simulation

- Results depend on quality of input data and user expertise. What you see may, or may not be what you get.
- Faster than prototyping.
- Less expensive than prototyping.
- Enables the engineering (hence optimization) of a design or process.
- Gives insight into why it "passes" or "fails"
- Allows for numerous "what if" studies.
- Helps in the understanding of the physics involved in the particular application.
- Can be fine-tuned with prototype/testing results.

FEA at the Click of a Button

Recall - FEA is an approximation and consists of three steps: > Pre Processing, > Analysis, > Post Processing. Originally these were distinct separate steps with different software packages to help the analyst.

Today with software packages such as Nastran, CosmosWorks, which can be "linked" to 3-D design software, this is done at the click of a button

What Can Go Wrong?

- FEA is an approximation
- Important to understand and select an appropriate analysis - Linear or non-linear.
- The software does not make this decision
- For example if:
 - Material properties are not constant (Non linear behaviour or part yields)
 - The force/load orientation changes
 - Physical movement (contact moves)
- Then the analysis must be Non-Linear or significant errors will be introduced
- The FEA expert or analyst <u>MUST</u> be consulted on these problems.

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Some Examples CSP Dual Pinch Contact – The Model



When fully loaded, the upper portions of the contact slide past each other due to the offset geometry.

CSP Contact Analysis Finite Element Model For the "Maximum Stress Case", these regions are displaced towards each other until self contact develops.
Some Examples CSP Dual Pinch Contact – Linear Analysis



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Some Examples CSP Dual Pinch Contact - Non Linear Analysis



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Some Examples 0.5 mm Pitch CSP Buckling Beam Contact

- FEA Allows analysis of "difficult-to-handle" micro-miniature parts
- Prototyping development virtually impossible.



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Some Examples 0.5 mm CSP Buckling Beam Contact – Linear



Results

- Maximum stress 143,000 psi
- Force /deflection curve



Some Examples 0.5 mm CSP Contact - Non Linear



Results

Maximum stress 106,000 psi
Force /deflection curve



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Some Examples Comparison Linear/Non Linear/experimental Results

- Maximum stress linear 143,000 psi
- Maximum stress non linear 106,000 psi
- Force /deflection

Linear Analysis prediction results in erroneous first pass approximation. Further Iterations would likely not converge to optimal design.



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Test Data

Closing Comments

- FEA is a tool which has revolutionized the world of design
- Care must be exercised to ensure that the results are meaningful
- Garbage in Garbage out.
- Our understanding is imperfect mistakes will still happen.
- Attempt to verify predications whenever possible.
- "It is difficult for outsiders to assess whether FEA work is being done effectively".
 - Peter Budgell (FEA Consultant)

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Chips on Fire, New Approach to Thermal Management

Kevin Moody, presenter

Kulicke & Soffa 3191 Corporate Place Hayward, CA 94545 Ph: (510)259-5050





Introduction

Thermal Management System

Test Results and Discussions

Summary



Introduction

- Two Die Sizes
 - Large Die: Integrated Heat Spreader (IHS)
 - Small Die: Bare die
- Large Die Challenges
 - Power is increasing
 - Die size is increasing (spreading resistance issues)
- Small Die Challenges
 - Power is increasing
 - Die size is decreasing (power density issues)

Power Density Trend



Power Dissipation



System Integration

• The K&S thermal control system features compact size and small footprint that makes it easy to integrate with system level testers and handlers, and provides straightforward maintenance

K&S Thermal Management System



System Level Tester

Automated Handlers

Lab Testing & Debug

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Thermal Management Options

THERMAL MANAGEMENT METHOD	ACCURACY & STABILITY	TEMP RANGE	THERMAL EFFICIENCY	DYNAMIC RESPONSE	COST	ENVIRONMENTAL & ERGONOMIC ISSUES
Refrigeration	Very High	Wide (Cool)	Very High	Very Fast	Very High	Yes
TCE w/Liquid	High	Wide (Cool & Heat)	Moderate- High	Fast	Moderate	Condensation (can be insulated)
Liquid	Low	Narrow (Cool)	High	Slow	Low	Condensation (can be insulated)
Active Heat Sink	Low	Narrow (Cool)	Moderate	Slow	Very Low	Noise & Vibration
Passive Heat Sink	Low	Narrow (Cool)	Low	Slow	Very Low	No

Thermal Management System

The K&S Thermal **Management System** utilizes Thermoelectric technology in conjunction with active liquid cooling for rapid thermal cycling (heating/cooling mode) or to regulate a steady temperature during testing.



Complete Thermal Management System



The heart of the K&S Thermal Management System is a Thermal Control Unit

03/08/04

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Thermal Control Unit





The TCU houses a Thermoelectric Cooler

Thermoelectric Cooling (TEC) employs Peltier Effect (cooling) and Joulian Effect (heating/I²R) to convert electricity to temperature differential. Using the TEC in the heating mode is very efficient because net heat (Joulian plus DUT) is pumped to the hot side.

03/08/04

Characteristic Curve Of a Thermoelectric Cooling (TEC)



TCU Function



TCU with Mounting Configuration



The TCU is also available in a mounting configuration for connection to an optional pneumatic actuator that provides automated application for higher throughput.



TCU with Hand latching Mechanism



The TCU is available with a hand latching mechanism for manual interface to an OZ TEK[®] test socket.



03/08/04

Applications

High Power Simulation
Temperature Characterization
High Volume Production Testing



Applications High Power Simulation

A new generation of high power IC devices dissipate significant heat flux that must be controlled during testing in order to produce accurate results. The K&S Thermal Management System can regulate a steady temperature (within ±2°C deviation at 100 W thermal load) between a set point temperature of -35° to +100°C during testing. This allows precise simulation of high power operation at a specific temperature or over a specific temperature range. The result is effective heat removal for higher quality data and improved production yields.



Applications

Temperature Characterization

The K&S Thermal Management System can control thermal cycling over a -35° to +100°C temperature range from at an average ramp rate of 5°C/sec with data acquisition as fast as 50 readings/sec. This allows for rapid dynamic response to the level of heat dissipation and more accurate power characterization of a device under test (DUT). The K&S Thermal Management System delivers better performance than thermal streams and is less expensive than refrigeration systems.



Applications

High Volume Production Testing

The K&S Thermal Management System is an effective alternative to conventional heat sink-fan cooling systems for high volume testing of production ICs. An optional pneumatic actuator provides automated application of the Thermal Control Unit (TCU) for higher throughput. The over-temperature protection feature gives safer ergonomic test procedure.



System Characteristics

Cooling Capacity: 120 W standard (higher capacity available) **Range:** -35° to +100°C (0 to 100 W) **Offset Precision:** ±2°C (100 W) *Ramp Rate:* 5°C/sec (higher rate available) **TCU Mount:** Manual – latching mechanism for manual interface to OZ TEK[®] socket Automatic – Pneumatic actuation **Test Capacity:** 1 or 2 packages with 2-channel thermal controller Up to 4 packages with 4-channel thermal controller Safety: Thermal Control Unit– Thermostat (set 35°C) for liquid over-temp protection Thermal Controller– LED indicates over-temp, and fuses provide protection *Environmental*: No freon, unlike refrigeration systems Quieter than conventional heat sink and fan systems No condensation **Other Features:** EMI Shield for the RTD sensor Isolated water lines With Elastomer washer for self leveling

TCU Thermal Performance



Case Temperature vs. Water Inlet Temperature



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Device Case Temperature at various DUT Heat Output



Device Case Temperature at various Contract Pressure



03/08/04

TCU Thermal Resistance using Graphite base interface Material



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Summary

• High power IC devices dissipate significant heat flux that must be controlled during testing.

•Thermoelectric technology with active liquid cooling provides optimized thermal cycling (heating/cooling mode) or regulate a steady temperature during testing

About Author

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2004 Burn-In & Test Socket Workshop

Heat Sink Modeling and Design For Dissipating High Heat S. Kumaran (Engineering Manager)





Outline

1) Objective

- Thermal Challenges
- Heat Sink Fundamental
- Heat Sink Technology
- Finned Heat Sink Model
- Design Considerations & High Power Thermal Solution
- ✓ Technology & Cost Comparison
- ✓ Summary
- ✓ References



> To present technology available

- Thermal solution that can dissipate high heat & to find the optimum heat sink
- Finned Heat Sink Model
2) Thermal Challenges

Nowadays, heat has become a major concern in the electronics industry.

Excessive heat is a major threat to device reliability.

> Following are the major challenges:-

- Heat loads of components increase exponentially.
- Space available for dissipation decreased.
- Cost Pressure.
- Prevent thermal Runaway.

3) Heat Sink Fundamental

- Heat sink is an integral part of a device cooling system and its importance must be emphasized.
- Heat generated in the component is due to the power lost I²R.
- This heat must be carried away by any means in order to keep device temperature within operating range, thus avoiding malfunction.

Heat sink performance usually is specified in terms of thermal resistance:-

Ts – Ta where Ts = ----- ?s=Thermal Resistance
Ts=Heat Sink Temp.
Ta=Ambient Temp.
Q=Heat input to heat sink

4) Heat Sink Technology

- Several types of heat sinks are available including:-
 - Heat-Pipe
 - Liquid Cooled Heat Sink
 - Forced Air Cooled Heat Sink
 - Natural Convection Heat Sink
 - Thermo Electric Cooler
- Natural Convection heat sink is satisfactory especially for device less than 5 watt.
- For majority applications, natural convection heat sink unable to remove the required amount of heat from the system.

4) Heat Sink Technology



Passive Heat Sink



ThermoElectric Cooler



Forced Air Cooled Heat Sink



Heat Sink Accessories

4) Heat Sink Technology





Liquid Cooled Heat Sink TEC with Liquid Cooled Heat S





Heat Pipe with fan cooled Heat

Heat Pipe



> Heat Pipe

• Often referred to as heat superconductor, heat pipe can quickly transfer heat from one point to another.

Very promising and increasingly popular because:-

- Uses effective evaporation and condensation cycles (latent heat) to extend surfaces available for dissipation.
- More packaging flexibility for heatsinks.
- Does not require mechanical pumps, valves or power hence more quiet and reliable.
- State of the art heat pipes can provide passive cooling for heat fluxes of over 200 W/cm².





Liquid-Cooling

- Typically, mixture of water and glycol can eliminate audible noise.
- Thus move heat away easily from the user area.
- Significantly increased system reliability.

Though yet to gain general market acceptance, as heat fluxes exceed 200 watts per square cm, heat pipe and liquid cooling are the only alternatives.



Fan-Cooled Heat sink Coolers

- Efficient method of removing heat
- Impingement cooling of heat sink by fan
- Result in low thermal resistance to cool almost any type of low heat generating device.

Air Cooling

- Is the conventional preference due to low system cost.
- Proven reliability and has been used for decades.
- Wide ranges of air cooled heat sinks are available to meet the needs.
- Air cooling is most effective for lower power & lower power density semiconductor components and a limiting factor in many high density system packages.

> Thermoelectric Cooler



- Unlike a simple heatsink, a thermoelectric cooler permits lowering the temperature of an object below ambient.
- Stabilizing the temperature of temperature sensitive device which are subject to widely varying ambient condition.

5) Finned Heat Sink Model

- Heat sinks are used to control the heat loads to its required level.
- Adding fins to the heat sink increases surface area, it also increase pressure drop.
- As a consequence it reduces the volumetric airflow, which also reduces the heat transfer coefficient.
- There surely exists a point at which the number of fins in a given area can be optimized to attain the highest performance operating under a given fan.
- A heat sink model is developed to find the optimum point for the heat sink design.

5) Finned Heat Sink Model (Cont')

> Thermal Resistance R

• The thermal resistance is obtained from :-

T.R = 1/ηfAfH where ηf = fin efficiency Af = fin profile area H = heat transfer coefficient

'H' varies due to the varying flow velocity in the channel with changing channel width, the optimized channel width can be obtained.

Heat transfer coefficient H is obtained from:-H = NuKair/L 5) Finned Heat Sink Model (Con't)
> Average Nusselt number

 Teertsra[2] proposed a composite model to calculate the average Nusselt number in a channel for fully developed and developing flow:-

Nug = [(Re*aPr/2)-3 + (0.664($\sqrt{Re*a}$)Pr1/3($\sqrt{(1+3.65)}$ Re*a)))-3]-1/3

> Approach Velocity Reynolds Number:-

• It is evaluated by taking the aspect ratio of the channel width to length and it is defined as

Re*a = (Vag/v) (g/L)

where v : viscosity of fluid Va: approach velocity g: Channel width L: Channel Length

- Perfect heat sink is capable of absorbing an unlimited quantity of heat without exhibiting any increases in temperature.
- Practically it is impossible, following must be taken into consideration when designing heat sink:-
 - Maximum power dissipation
 - Heat dissipation area
 - Maximum ambient temperature
 - Maximum case temperature
 - Maximum junction temperature
 - Minimum air flow if applicable
 - Maximum weight and size

- Consumer application
 - Heat pipe technology in notebook etc.
- ii) Burn-In Solution
 - Individual DUT Thermal Control in Burn-In System.

- Consumer application (Heat Pipe)
- Diagram illustrate the use of heat pipe technology in the cooling of processor base notebooks.



- Can eliminate the use of liquid pump & fan.
- Reliable and no power required.
- Can be formed to meet space availability.
- Low delta T hence can provide maximum surface area.
- Minimize volume and weight.



- Heat Pipe potential and application
- The table below illustrates the potential of heat pipe technology in cooling processor with heat flux in excess of 200 w/cm².

Summary of prototype heat pipe test result Shows the potential of the emerging technology (Combined Pulsating and Capillary Transport Mechanism)

Heat Pipe	Heat Pipe		Thermal
Mechanism	Fill Ratio	Heat Flux	Resistance
СРСТ	50%	160W/cm ²	0.60 ⁰ C/W
СРСТ	55%	175W/cm ²	0.38 ⁰ C/W
СРСТ	60%	175W/cm ²	0.27 ⁰ C/W
СРСТ	70%	220W/cm ²	0.16 ⁰ C/W
СРСТ	80%	185W/cm ²	0.20 ⁰ C/W



6. THERMAL DESIGN & SOLUTION (Con't)



6. THERMAL DESIGN & SOLUTION (Con't)

- Customised heat sink (passive, active, liquid cool, heatpipe) with heater/TEC will be used for the individual DUT thermal control.
- Temperature sensor mounted at the heat sink baseplate as to monitor the device temperature.
- Temperature monitoring and controlling is controlled by the Temperature controller board.
- Thermal interface material to cushion die surface.
- Chamber airflow is used to cool DUTs.
- Device power variation is compensated by individual Heater or TEC.

7. Technology & Cost Comparison

Thermal Technology	Thermal Efficiency	Heat Flux (W/cm ²)	Thermal Resistance °C/W	Cost (10 W Device)	Cost (50 W Device)	Cost (100W Device)	Cost (200W Device)
Heat Pipe	Very High	<220	0.16	55	60	~160	~260
Liquid Cooling	High	<150	0.4	150	150	160	Na
Forced Convection Cooling	Moderate	<50	0.8	10	20	Na	Na
Passive HeatSink	Low	<10	3	5	Na	Na	Na

8. Summary

In conclusion:

Heat pipe Technology

• The high heat flux heat pipe technology will advance the state-of-the-art and able to provide robust and efficient cooling for future hotter electronics.

> Heat pipes are now being combined with other technologies (liquid cooled etc) as to meet these emerging requirements.

9. Questions



Passive Heat Sink



Forced Air cooled Heat Sink



Thermocouple wire



ThermoElectric Cooler



Liquid Cooled Heat Sink



TEC with Liquid Cool Heat Sink



Heat Pipe



Heat Pipe with Heat Sink



Heat Pipe with fan cooled Heat Sink

10. Main References

- H.Xie, M.Aghazadeh, "The use of heat Pipes in the cooling of portables with high power packages," Proc. 45th Electronic Components and Technology Conference, May 1995, Las Vegas, Nevada
- 2) Teertstra P., Yovanovich M.M., Culham J.R., and Lemezyk T., "Analytical Forced Convection Modelling of Plate Fin Heat Sinks", Proceedings of 15th IEEE Semiconductor Thermal Measurement & Management Symposium, pp. 34-41, San Diego, CA, March 9-11, 1999.

3) White F.M., 1991, Heat and Mass Transfer, Addison-Wesley